

Form PTO 1449 U.S. DEPARTMENT OF COMMERCE
(Modified) PATENT AND TRADEMARK OFFICE

DOCKET NO.

9550-015-27

SERIAL NO.

10/620,332

LIST OF REFERENCES CITED BY APPLICANT
(Use Several Sheets if Necessary)

APPLICANT

John C. VOYTA et al.

FILING DATE

July 17, 2003

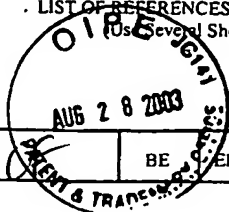
GROUP ART UNIT

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
cf	AA	5,112,960	05/1992	BRONSTEIN et al.	536	18.1	Aug. 30, 1990
cf	AB	5,145,772	09/1992	VOYTA et al.	435	4	Sep. 30, 1991
cf	AC	5,225,584	07/1993	BROOKS et al.	558	189	Apr. 3, 1991
cf	AD	5,336,596	08/1994	BRONSTEIN et al.	435	6	Oct. 23, 1991
cf	AE	5,547,836	08/1996	BRONSTEIN et al.	435	6	Mar. 15, 1993
cf	AF	5,593,828	01/1997	BRONSTEIN et al.	435	6	Apr. 26, 1994
cf	AG	5,731,445	03/1998	MATSUMOTO et al.	549	464	Dec. 2, 1996
cf	AH	5,827,650	10/1998	BRONSTEIN et al.	435	6	Jan. 23, 1996
cf	AI	5,849,495	12/1998	BRONSTEIN et al.	435	6	Mar. 4, 1997
cf	AJ	6,232,068	05/2001	LINSLEY et al.	435	6	Jan. 22, 1999
cf	AK	6,251,685	06/2001	DORSEL et al.	436	172	Feb. 18, 1999
cf	AL	6,284,899	09/2001	SCHAAP et al.	549	332	Nov. 28, 1997
cf	AM	6,461,876	10/2002	GIRI	436	546	Aug. 21, 2000
cf	AN	2001/0053497	12/2001	PATIL et al.	430	270.1	Jul. 20, 2001
cf	AO	2001/0053527	12/2001	PATIL et al.	4335	6	Jul. 20, 2001
cf	AP	2002/0110828	08/2002	FEREA et al.	435	6	Jan. 14, 2002
	AQ	2002/0246730	10/2002	LIU et al.	435	6	Dec. 19, 2001

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
cf	AR	WO99/53319	10/1999	WIPO	YES	
cf	AS	WO00/75374	12/2000	WIPO	YES	
cf	AT	WO01/62377	08/2001	WIPO	YES	
cf	AU	WO01/12856	02/2001	WIPO	YES	
cf	AV	WO01/25485	04/2001	WIPO	YES	
cf	AW	WO01/29261	04/2001	WIPO	YES	
cf	AX	WO01/69245	09/2001	WIPO	YES	
cf	AY	WO01/73119	10/2001	WIPO	YES	
cf	AZ	WO01/73134	10/2001	WIPO	YES	
cf	BA	WO01/75159	10/2001	WIPO	YES	

Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE		DOCKET NO. 9550-015-27		SHEET <u>2</u> OF <u>2</u> SERIAL NO. 10/620,332	
LIST OF REFERENCES CITED BY APPLICANT (Use Several Sheets if Necessary)		APPLICANT John C. VOYTA et al.			
		FILING DATE July 17, 2003		GROUP ART UNIT	
	BE EP 1 038 876	09/2000	EPO		YES
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)					
<i>cf</i>	BF	<u>Akhavan-Tafti, et al.</u> , "Chemiluminescent Detection of DNA in Low-and Medium-Density Arrays", Clinical Chemistry, 44, No. 9 (1998).			
<i>cf</i>	BG	<u>Dawson, et al.</u> , "Membrane-Based Microarrays", SPIE Conference on Chemical Microsensors and Applications II, SPIE, Vol. 3857, 31-37 (1999).			
<i>cf</i>	BH	<u>Cheek, et al.</u> , "Chemiluminescence Detection for Hybridization Assays on the Flow-Thru Chip, a Three-Dimensional Microchannel Biochip", Analytical Chemistry, 73, 5777-5783 (2001).			
EXAMINER <i>[Signature]</i>			DATE CONSIDERED <i>6/22/05</i>		
*EXAMINER: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.					

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1645

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
CF	AA	2003/0134286	7/17/03	EDWARDS, et al.			
	AB	6,668,979	5/30/00	AKHAVAN-TAFTI, et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
CF	AK	WO 99/54503	10/28/99	WIPO	X
	AL				
	AM				
	AN				
	AO				

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AP	
	AQ	
	AR	
	AS	

EXAMINER

John C. Voyta

DATE CONSIDERED

6/22/05

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